JJMICROELECTRONICS

60V, 79A, 8mΩ N-channel Power Trench MOSFET JMSL0608PG

Features

- Excellent $R_{\text{DS(ON)}}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant
- Pb-free plating

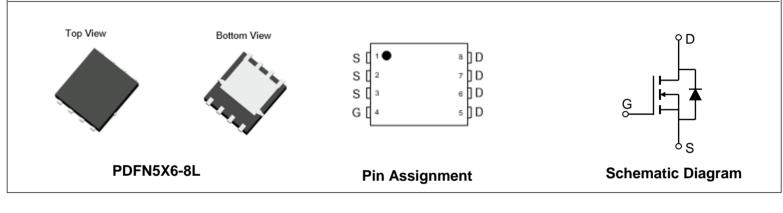
Applications

- Load Switch
- PWM Application
- Power Management

Product Summary

Parameters	Value	Unit
V _{DSS}	60	V
V _{GS(th)_Typ}	1.7	V
I _D (@V _{GS} =10V)	79	А
$R_{DS(ON)_Typ}(@V_{GS}=10V$	6.2	mΩ
R _{DS(ON)_Typ} (@V _{GS} =4.5V	8.0	mΩ





Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSL0608PG	SL0608P	1	Tape&Reel	PDFN5x6-8L	5000	50000

Absolute Maximum Ratings (@ T_c = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V _{DS}	Drain-to-Source Voltage		60	V
V _{GS}	Gate-to-Source Voltage		±20	V
1	Continuous Drain Current	$T_{C} = 25^{\circ}C$	79	A
ι _D		$T_{\rm C} = 100^{\circ}{\rm C}$	50	A
I _{DM}	Pulsed Drain Current ⁽¹⁾		Refer to Fig.4	A
E _{AS}	Single Pulsed Avalanche Energy ⁽²⁾		89	mJ
P _D	Power Dissipation	$T_C = 25^{\circ}C$	89	w
		$T_{c} = 100^{\circ}C$	36	vv
T _J , T _{STG}	Junction & Storage Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Мах	Unit
R_{\thetaJA}	Thermal Resistance, Junction to Ambient ⁽³⁾	44	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.4	C/ VV

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	l aracteristics	Į				
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48V, V_{GS} = 0V$	-	-	1.0	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics	-		1		<u>8</u>
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.2	1.7	2.2	V
D		$V_{GS} = 10V, I_D = 20A$	-	6.2	8.0	mΩ
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 4.5V, I_{D} = 15A$	-	8.0	10.4	mΩ
Dynami	ic Characteristics					
R_g	Gate Resistance	f = 1MHz	-	1.6	-	Ω
C_{iss}	Input Capacitance		852	1192.7	1610	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 30V,$ f = 1MHz	375	525	709	pF
C _{rss}	Reverse Transfer Capacitance		26	36	49	pF
Qg	Total Gate Charge		16	22	30	nC
Q _{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 30V, I_D = 20A$	3	4	5	nC
Q_gd	Gate Drain("Miller") Charge	$v_{\rm DS} = 50 v, v_{\rm D} = 20 A$	4	5	7	nC
	•	•		•		•
Switchi	ng Characteristics				-	T
t _{d(on)}	Turn-On DelayTime		-	8	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 30V$	-	20	-	ns
t _{d(off)}	Turn-Off DelayTime	I_D = 20A, R_{GEN} = 3 Ω	-	22	-	ns
t _f	Turn-Off Fall Time		-	7	-	ns
Body D	iode Characteristics					
I _S	Maximum Continuous Body Diode Forward Current		-	-	79	A
I _{SM}	Maximum Pulsed Body Diode Forward Current		-	-	315	А
$V_{\rm SD}$	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	L = 200 di/dt 1000 /va	22	31	41	ns
Qrr	Body Diode Reverse Recovery Charge	– I _F = 20A, di/dt = 100A/us	-	22.8	-	nC

Electrical Characteristics ($T_J = 25^{\circ}C$ unless otherwise specified)

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

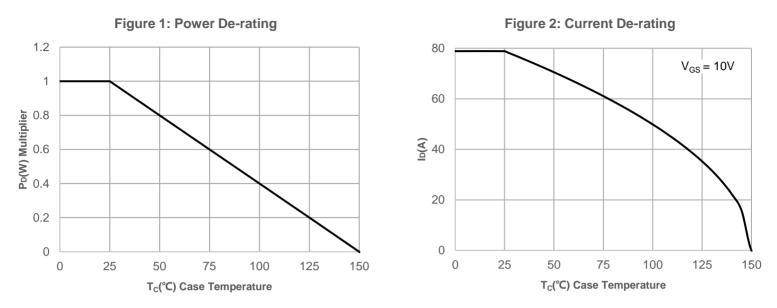
2. E_{AS} condition: Starting T_J =25C, V_{DD} =30V, V_G =10V, R_G =25ohm, L=3mH, I_{AS} =7.7A, V_{DD} =0V during time in avalanche.

3. $R_{\theta JA}$ is measured with the device mounted on a 1inch 2 pad of 2oz copper FR4 PCB.

4. Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 0.5%.

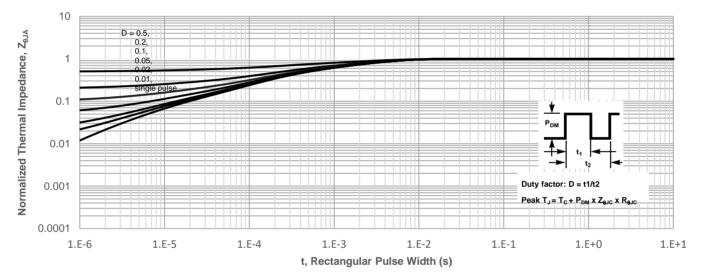




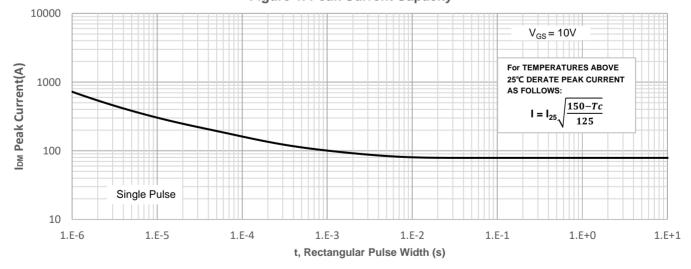


Typical Performance Characteristics

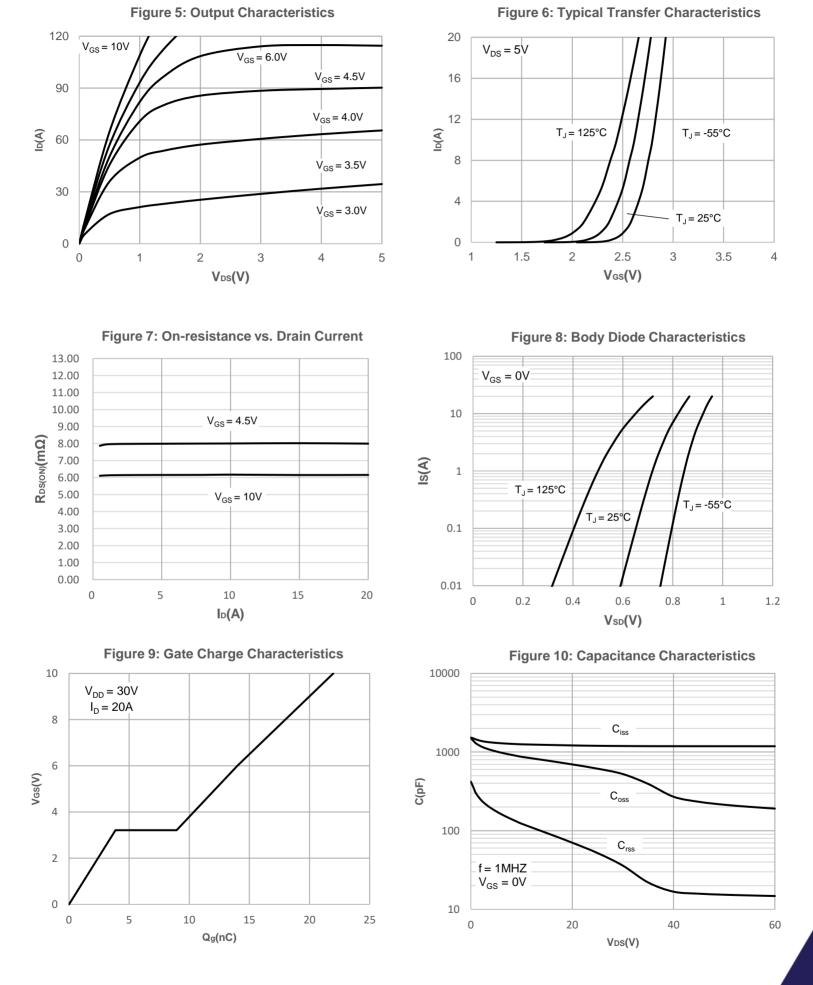












Typical Performance Characteristics

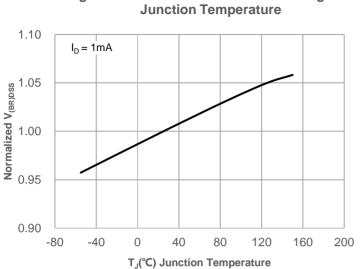
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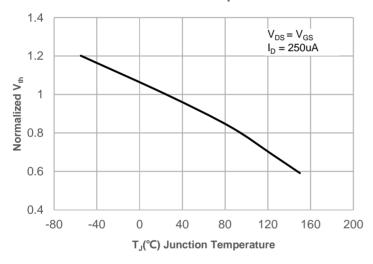


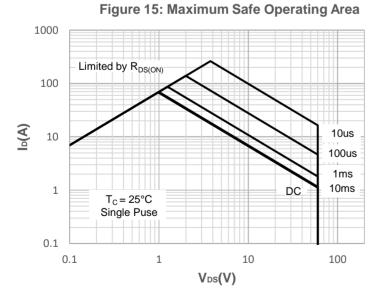
Typical Performance Characteristics

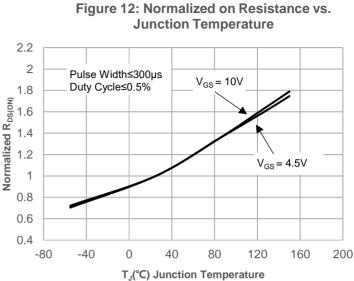
Figure 11: Normalized Breakdown voltage vs.



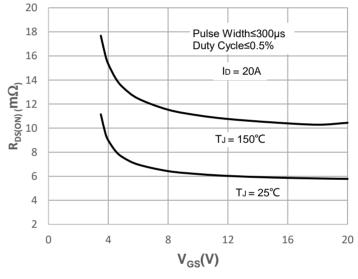












Normalized R_{DS(ON)}

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Test Circuit

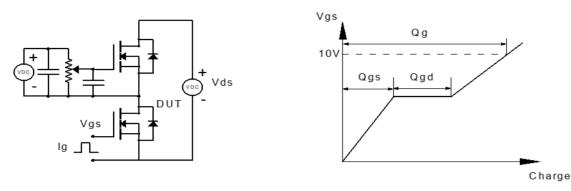


Figure 1: Gate Charge Test Circuit & Waveform

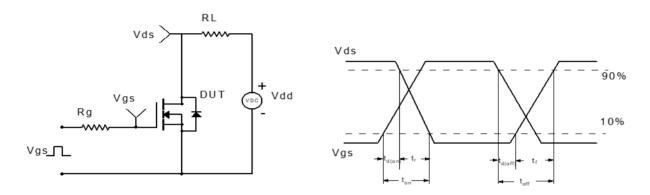


Figure 2: Resistive Switching Test Circuit & Waveform

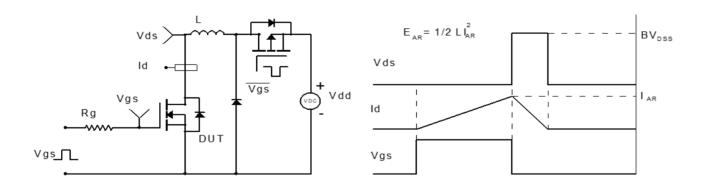


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

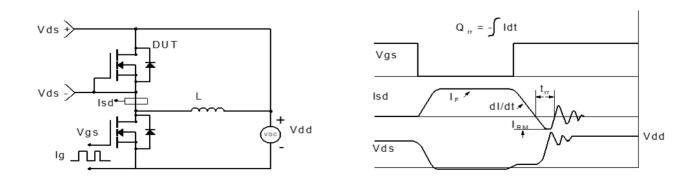
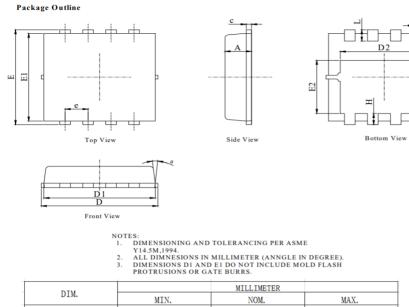


Figure 4: Diode Recovery Test Circuit & Waveform

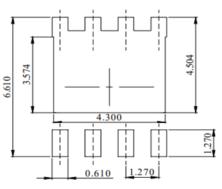


Package Mechanical Data(PDFN5X6-8L)



Dim.	MIN.	NOM.	MAX.
А	0.90	1.00	1.10
b	0.31	0. 41	0.51
с	0.20	0.25	0.30
D	5.00	5.20	5.40
D1	4.95	5.05	5.15
D2	4.00	4.10	4.20
E	6.05	6.15	6.25
E1	5.50	5.60	5.70
E2	3. 42	3. 53	3.63
е	1. 27BSC		
Н	0.60	0.70	0.80
L	0.50	0.70	0.80
К	1.23 REF		
θ	-	-	10°

Recommended Soldering Footprint



DIMENSIONS:MILLIMETERS

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